

# Sound Classification

---

Juan Pablo Bello

EL9173 Selected Topics in Signal Processing: Audio Content Analysis

NYU Poly

# Classification

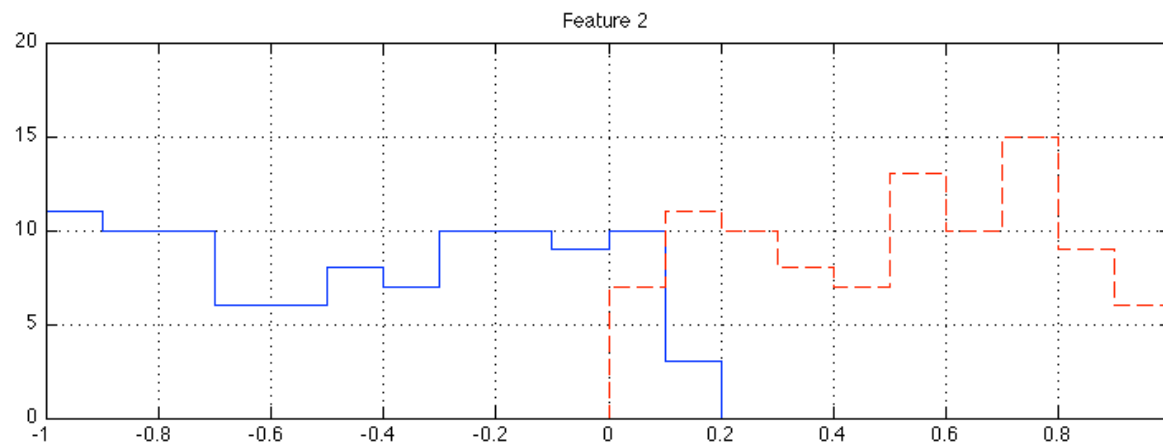
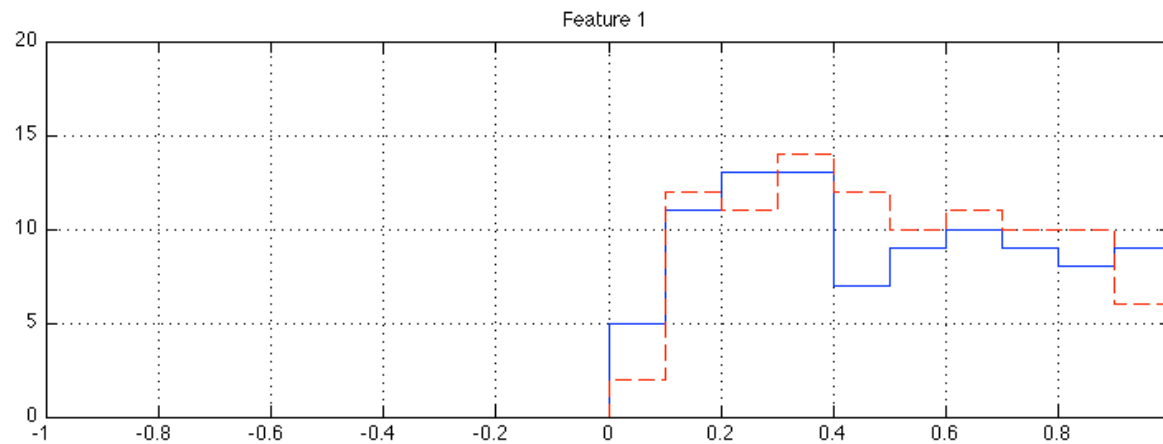
---

- It is the process by which we automatically assign an individual item to one of a number of categories or classes, based on its characteristics.
- In our case:
  - (1) the items are audio signals (e.g. sounds, tracks, excerpts);
  - (2) their characteristics are the features we extract from them (MFCC, chroma, centroid);
  - (3) the classes (e.g. speakers, instruments, phones, sound environment) fit the problem definition
- The complexity lies in finding an appropriate relationship between features and classes

# Example

---

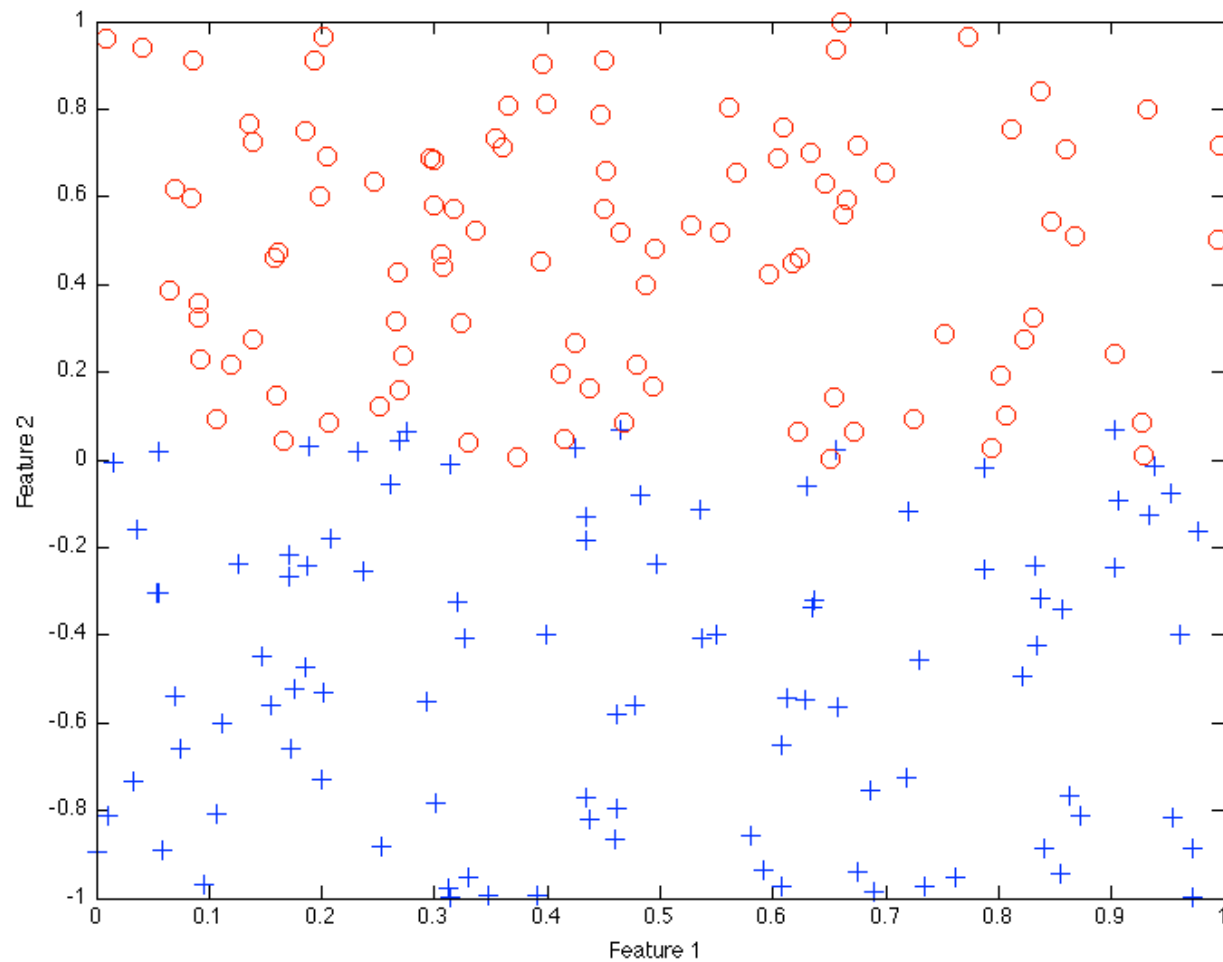
- 200 sounds of 2 different kinds (red and blue); 2 features extracted per sound



# Example

---

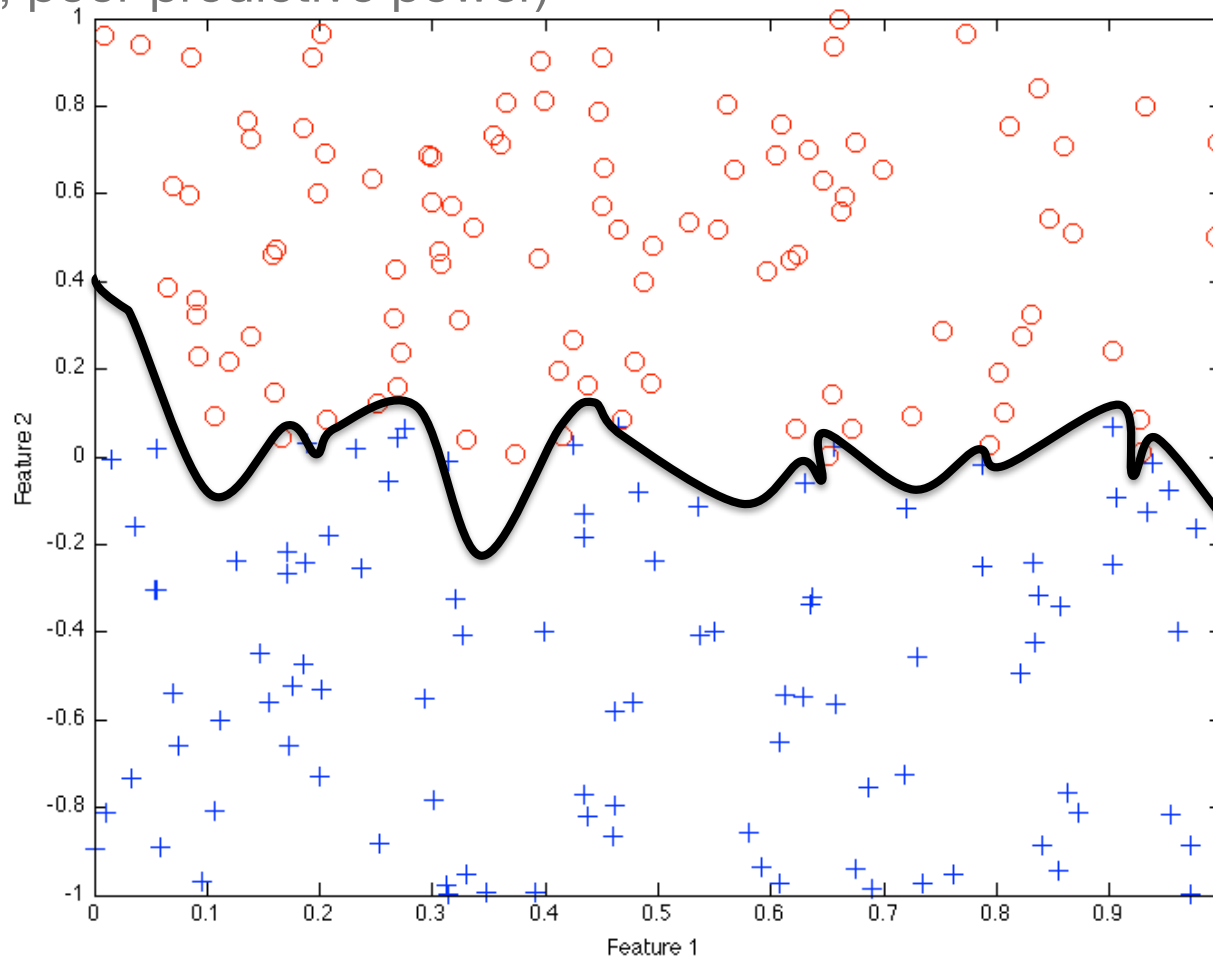
- The 200 items in the 2-D feature space



# Example

---

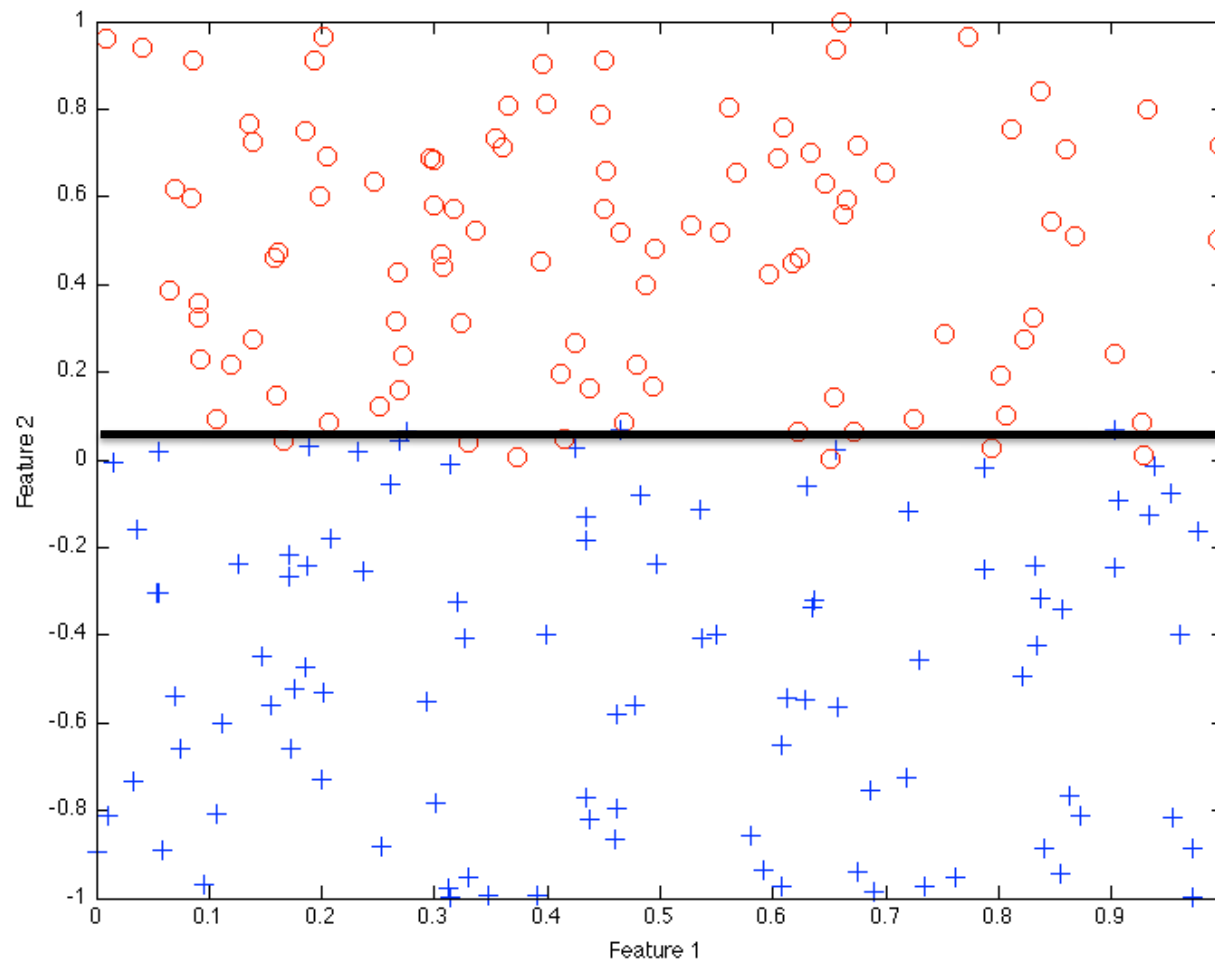
- Boundary that optimizes performance -> risk of overfitting (excessive complexity, poor predictive power)



# Example

---

- Generalization -> Able to correctly classify novel input



# Classification of audio signals

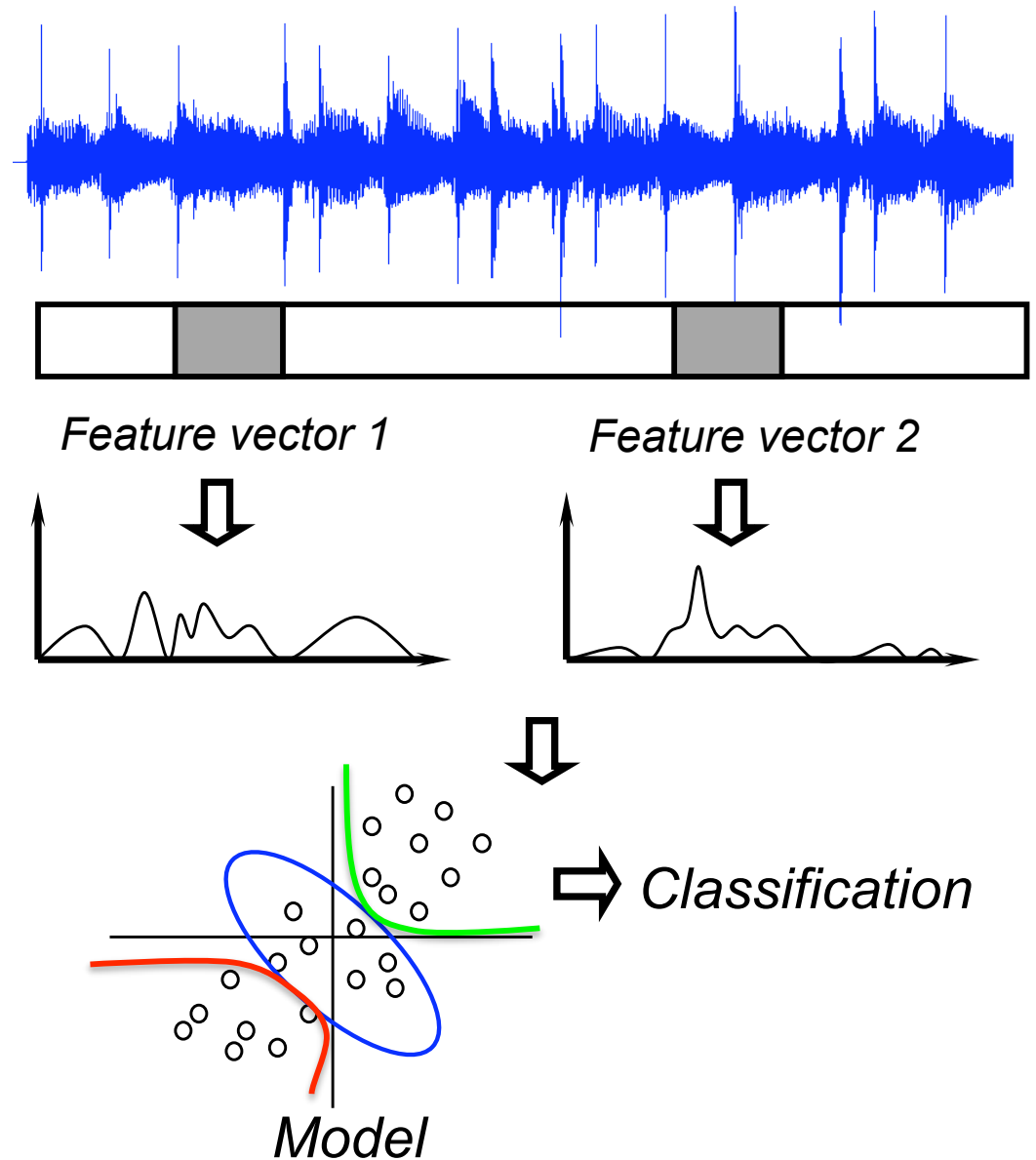
---

- A number of relevant tasks:
  - Source Identification
  - Automatic Speech Recognition
  - Automatic Music Transcription
  - Labeling/Classification/Tagging
  - Music/Speech/Environmental Sound Segmentation
  - Sentiment/Emotion Recognition
- Common machine learning techniques applied in related fields (e.g. image, natural language processing)

# An audio classifier

---

- Feature extraction: (1) feature computation; (2) summarization
- Pre-processing: (1) normalization; (2) feature selection
- Classification: (1) use sample data to estimate boundaries, distributions or class-membership; (2) classify new data based on these estimations





# Feature set (recap)

---

- Feature extraction is necessary as audio signals carry too much redundant and/or irrelevant information
- They can be estimated on a frame by frame basis or within segments, sounds or tracks.
- Many possible features: spectral, temporal, pitch-based, etc.
- A good feature set is a must for classification
- What should we look for in a feature set?

# Feature set (what to look for?)

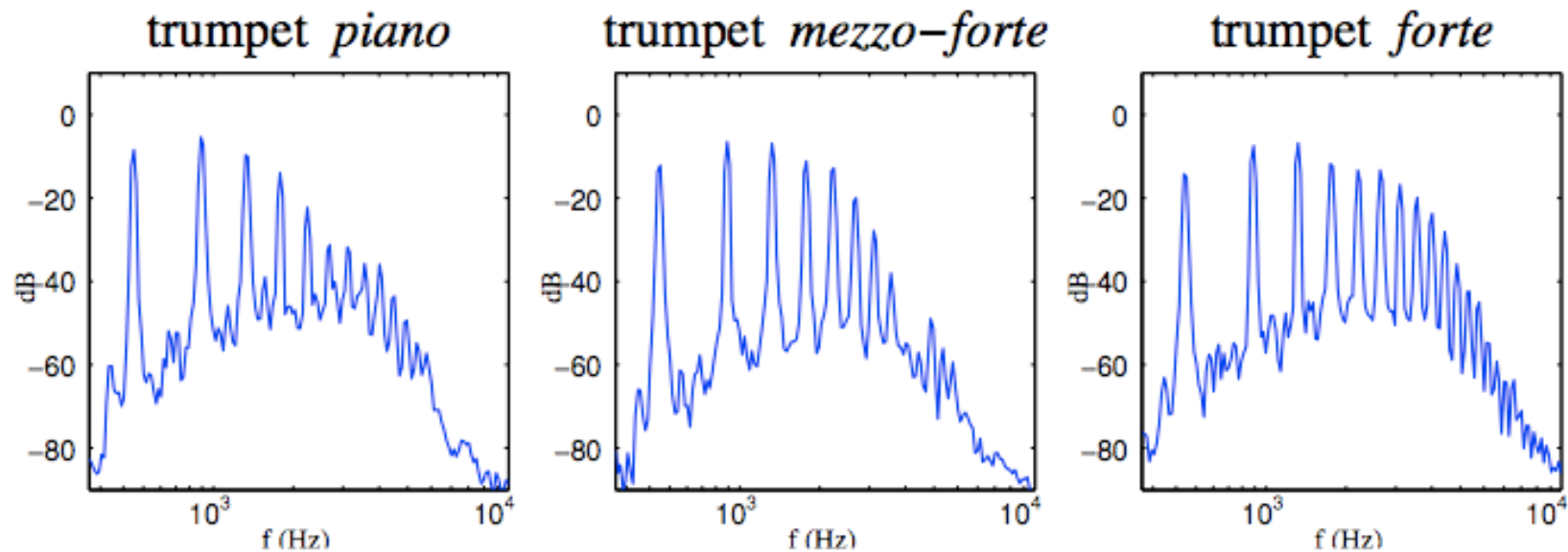
---

- A few issues of feature design/choice:
- Can be robustly estimated from available audio (e.g. spectral envelope vs onset rise times in polyphonies)
- Relevant to classification task (e.g. MFCC vs chroma for source ID) -> noisy features make classification more difficult!
- Feature set should be as invariant as possible to changes within the natural class' range

# Feature set (what to look for?)

---

- We expect variability within sound classes
- For example: trumpet sounds change considerably between, e.g. different loudness levels, pitches, instruments, playing style or recording conditions

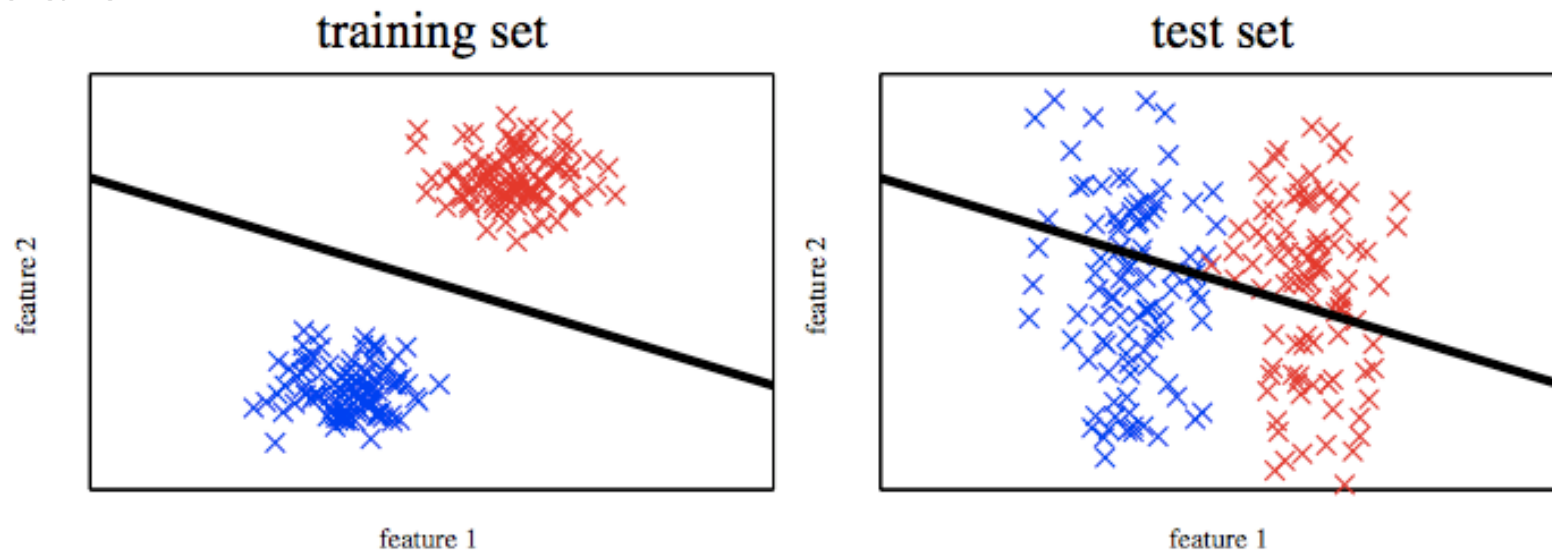


- Classes are never fully described by a point in the feature space but by the distribution of a sample population

# Features and training

---

- Class models must be learned on many sounds to properly account for between/within class variations
- The natural range of features must be well represented on the sample population

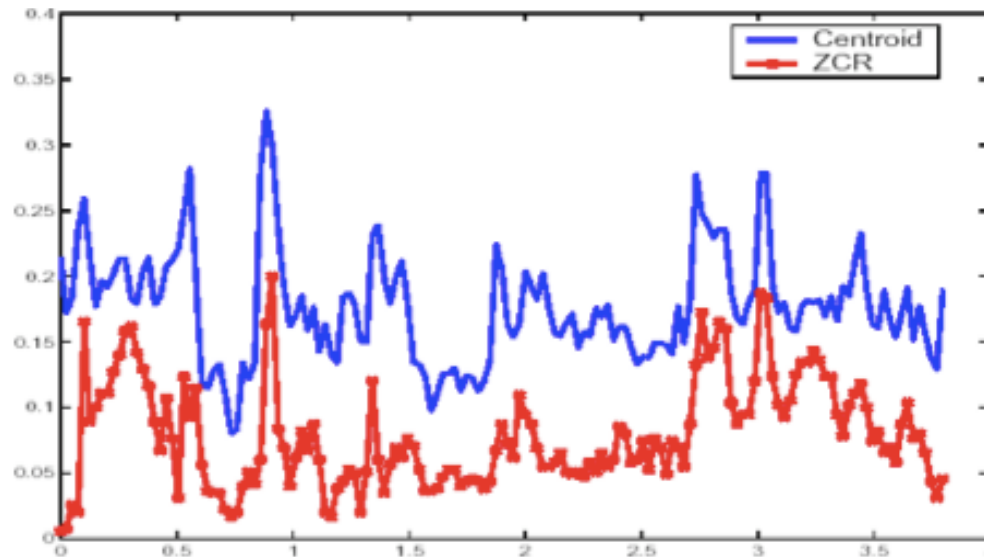


- Failure to do so leads to overfitting: training data only covers a sub-region of its natural range and class models are inadequate for new data.

# Feature set (what to look for?)

---

- Low(er) dimensional feature space -> Classification becomes more difficult as the dimensionality of the feature space increases.

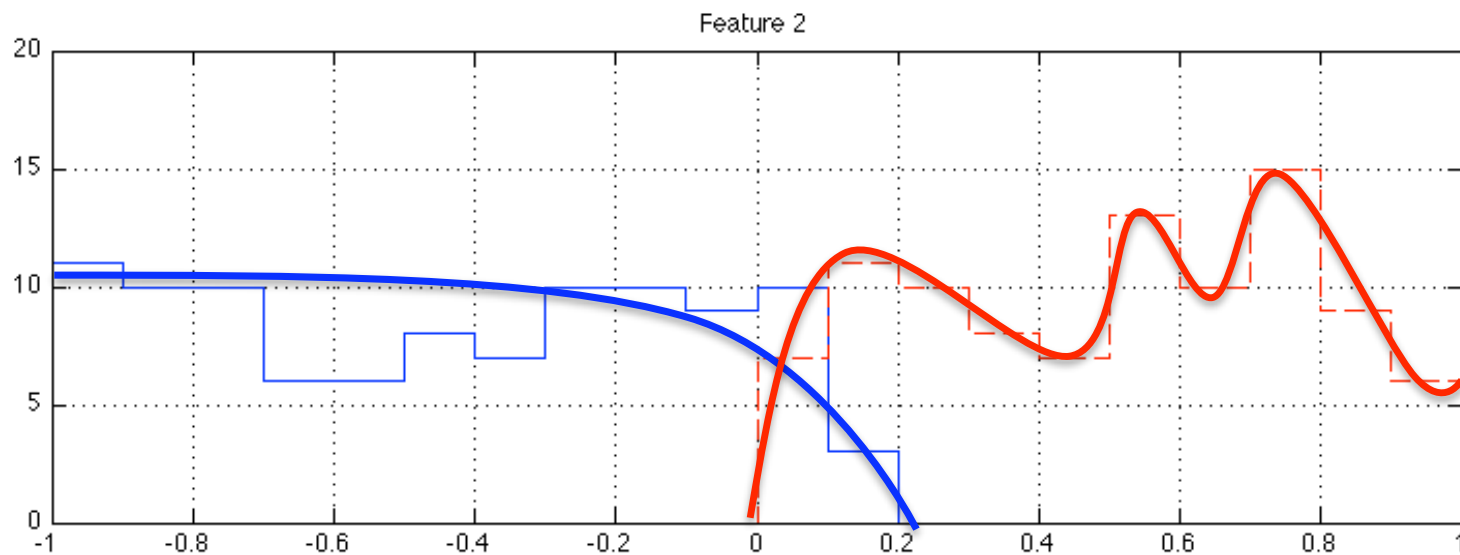


- As free from redundancies (strongly correlated features) as possible
- Discriminative power: good features result in separation between classes and grouping within classes

# Feature distribution

---

- Remember the histograms of our example. They describe the behavior of features across our sample population.



- It is desirable to parameterize this behavior

# Feature distribution

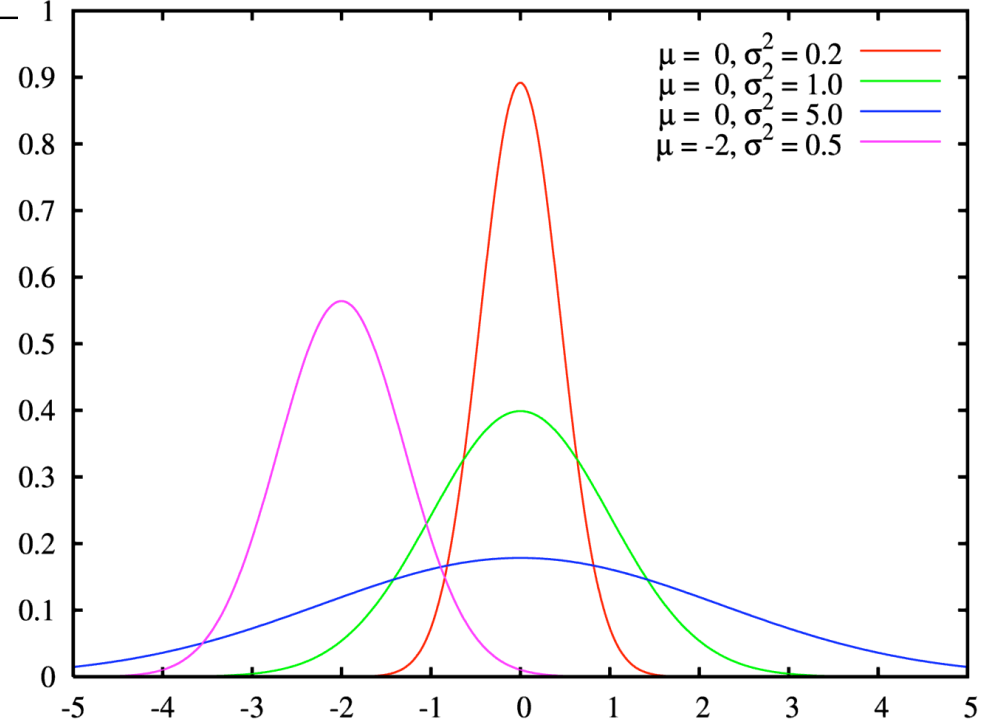
---

- A Normal or Gaussian distribution is a bell-shaped probability density function defined by two parameters, its mean ( $\mu$ ) and variance ( $\sigma^2$ ):

$$\mathcal{N}(x_l; \mu, \sigma) = \frac{1}{\sigma\sqrt{2\pi}} e^{-\frac{(x_l - \mu)^2}{2\sigma^2}}$$

$$\mu = \frac{1}{L} \sum_{l=1}^L x_l$$

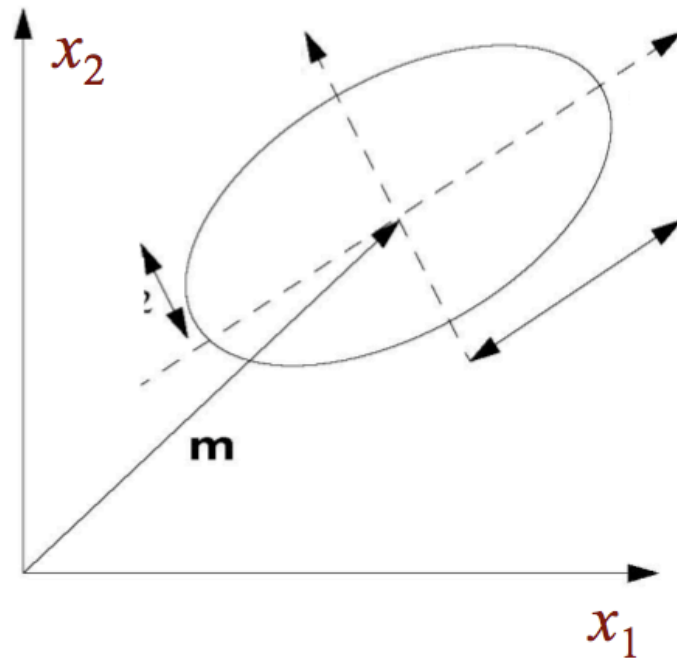
$$\sigma^2 = \frac{1}{L} \sum_{l=1}^L (x_l - \mu)^2$$



# Feature distribution

---

- In D-dimensions, the distribution becomes an ellipsoid defined by a D-dimensional mean vector and a DxD covariance matrix:



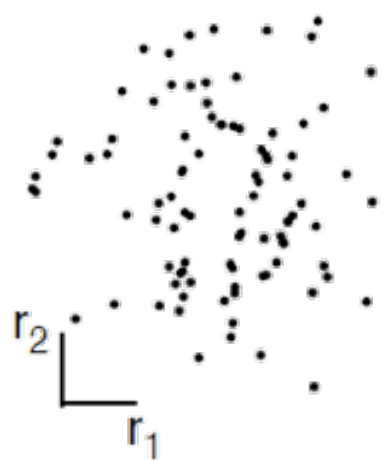
$$C(x, y) = \frac{1}{L} \sum_{l=1}^L (x_l - \mu_x)(y_l - \mu_y)$$



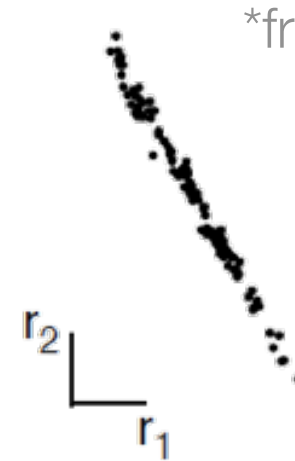
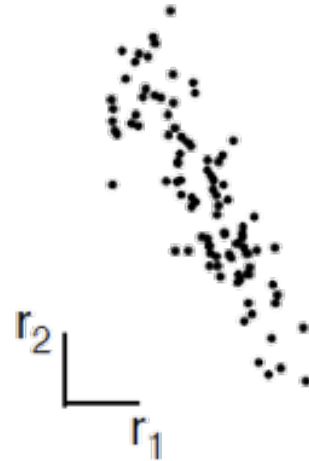
# Feature distribution

---

- $C_x$  is a square symmetric  $D \times D$  matrix: diagonal components are the feature variances; off-diagonal terms are their co-variances



low redundancy



high redundancy

\*from Shlens, 2009

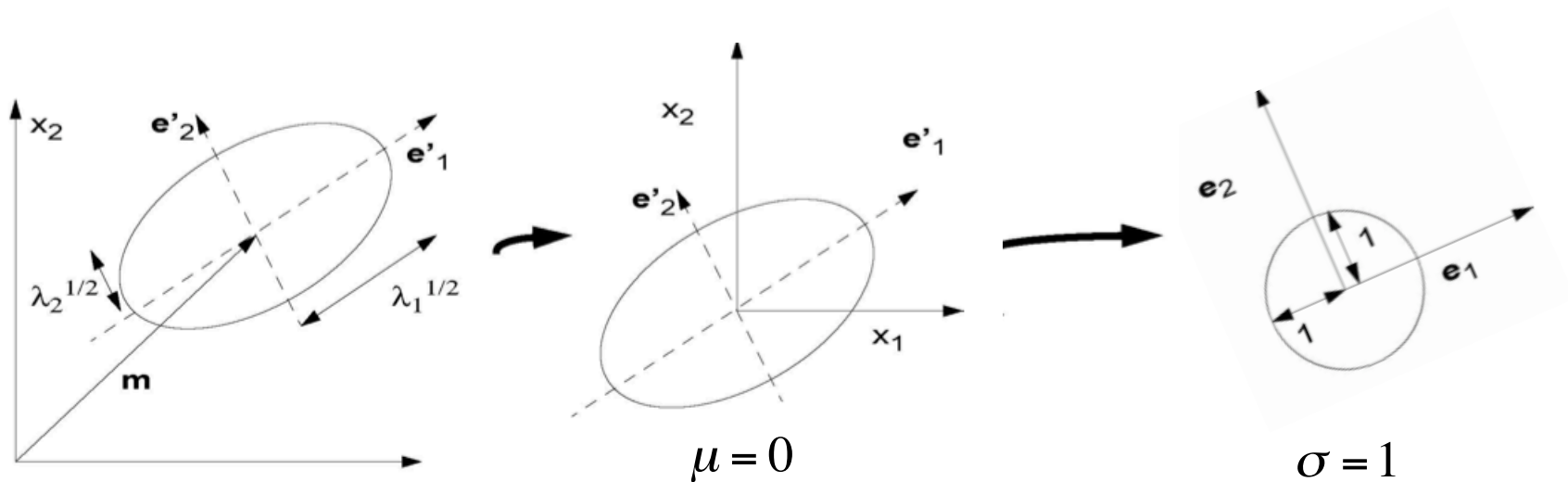
- High covariance between features shows as a narrow ellipsoid (high redundancy)

# Data normalization

---

- To avoid bias towards features with wider range, we can normalize all to have zero mean and unit variance:

$$\hat{x} = (x - \mu) / \sigma$$



# PCA

---

- Complementarily we can minimize redundancies by applying Principal Component Analysis (PCA)
- Let us assume that there is a linear transformation  $A$ , such that:

$$Y = AX$$

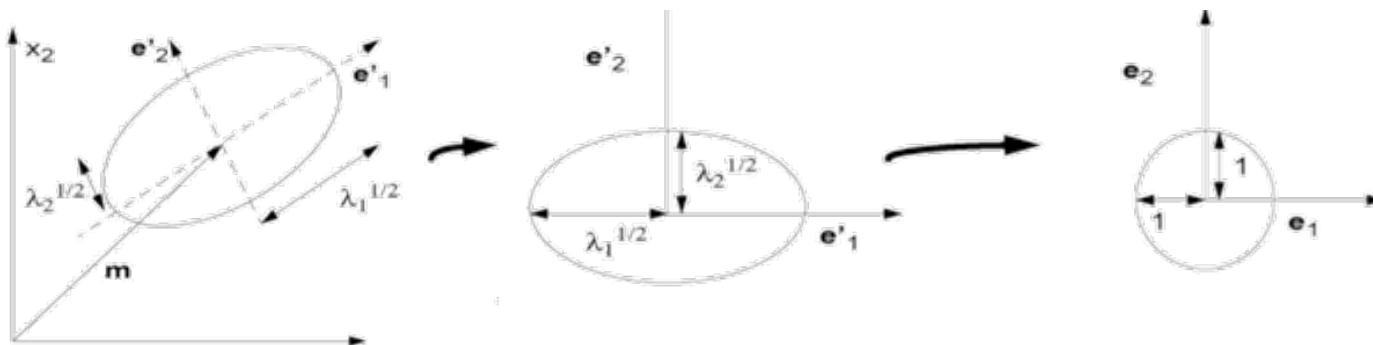
$$\begin{bmatrix} \mathbf{a}_1 \cdot \mathbf{x}_1 & \cdots & \mathbf{a}_1 \cdot \mathbf{x}_L \\ \vdots & \ddots & \vdots \\ \mathbf{a}_D \cdot \mathbf{x}_1 & \cdots & \mathbf{a}_D \cdot \mathbf{x}_L \end{bmatrix} = \begin{bmatrix} \mathbf{a}_1 \\ \mathbf{a}_2 \\ \vdots \\ \mathbf{a}_D \end{bmatrix} \begin{bmatrix} \mathbf{x}_1 & \mathbf{x}_2 & \cdots & \mathbf{x}_L \end{bmatrix}$$

- Where  $\mathbf{x}_i$  are the  $D$ -dimensional feature vectors (after mean removal) such that:  $C_x = XX^T/L$

# PCA

---

- What do we want from  $Y$ :
  - Decorrelated: All off-diagonal elements of  $C_Y$  should be zero
  - Rank-ordered: according to variance
  - Unit variance
- $A \rightarrow$  orthonormal matrix; rows = principal components of  $X$



# PCA

---

- How to choose A?

$$C_y = \frac{1}{L} Y Y^T = \frac{1}{L} (AX)(AX)^T = A \left( \frac{1}{L} X X^T \right) A^T = A C_x A^T$$

- Any symmetric matrix (such as  $C_x$ ) is diagonalized by an orthogonal matrix E of its eigenvectors

- For a linear transformation Z, an eigenvector  $e_i$  is any non-zero vector that satisfies:

$$Z e_i = \lambda_i e_i$$

- Where  $\lambda_i$  is a scalar known as the eigenvalue
- PCA chooses  $A = E^T$ , a matrix where each row is an eigenvector of  $C_x$

# PCA

---

- In MATLAB:

```
function [signals,PC,V] = pca1(data)
% PCA1: Perform PCA using covariance.
%   data - MxN matrix of input data
%         (M dimensions, N trials)
%   signals - MxN matrix of projected data
%   PC - each column is a PC
%   V - Mx1 matrix of variances

[M,N] = size(data);

% subtract off the mean for each dimension
mn = mean(data,2);
data = data - repmat(mn,1,N);

% calculate the covariance matrix
covariance = 1 / (N-1) * data * data';

% find the eigenvectors and eigenvalues
[PC, V] = eig(covariance);

% extract diagonal of matrix as vector
V = diag(V);

% sort the variances in decreasing order
[junk, rindices] = sort(-1*V);
V = V(rindices);
PC = PC(:,rindices);

% project the original data set
signals = PC' * data;
```

From <http://www.sn1.salk.edu/~shlens/pub/notes/pca.pdf>

# Dimensionality reduction

---

- Furthermore, PCA can be used to reduce the number of features:
- Since  $A$  is ordered according to eigenvalue  $\lambda_i$  from high to low
- We can then use an  $M \times D$  subset of this reordered matrix for PCA, such that the result corresponds to an approximation using the  $M$  most relevant feature vectors
- This is equivalent to projecting the data into the few directions that maximize variance
- We do not need to choose between correlating (redundant) features, PCA chooses for us.
- Can be used, e.g., to visualize high-dimensional spaces

# Discrimination

---

- Let us define:

Proportion of occurrences of class  $k$  in the sample

$$S_w = \sum_{k=1}^K (L_k/L) C_k$$

Within-class scatter matrix

Covariance matrix for class  $k$

$$S_b = \sum_{k=1}^K (L_k/L) (\mu_k - \mu) (\mu_k - \mu)^T$$

global mean

Between-class scatter matrix

Mean of class  $k$



# Discrimination

---

- $\text{Trace}\{U\}$  is the sum of all diagonal elements of  $U$ , s.t.:
- $\text{Trace}\{S_w\}$  measures average variance of features across all classes
- $\text{Trace}\{S_b\}$  measures average distance between class means and global mean across all classes
- The discriminative power of a feature set can be measured as:

$$J_0 = \frac{\text{trace}\{S_b\}}{\text{trace}\{S_w\}}$$

- High when samples from a class are well clustered around their mean (small  $\text{trace}\{S_w\}$ ), and/or when different classes are well separated (large  $\text{trace}\{S_b\}$ ).

# Feature selection

---

- But how to select an optimal subset of  $M$  features from our  $D$ -dimensional space that maximizes class separability?
- We can try all possible  $M$ -long feature combinations and select the one that maximizes  $J_0$  (or any other class separability measure)
- In practice this is unfeasible as there are too many possible combinations
- We need either a technique to scan through a subset of possible combinations, or a transformation that re-arranges features according to their discriminative properties

# Feature selection

---

- Sequential backward selection (SBS):
  1. Start with  $F = D$  features.
  2. For each combination of  $F-1$  features (inc. chosen  $F$ ) compute  $J_0$
  3. Select the combination that maximizes  $J_0$
  4. Repeat steps 2 and 3 until  $F = M$
- Good for eliminating bad features; nothing guarantees that the optimal  $(F-1)$ -dimensional vector has to originate from the optimal  $F$ -dimensional one.
- Nesting: once a feature has been discarded it cannot be reconsidered

# Feature selection

---

- Sequential forward selection (SFS):
  1. Select the individual feature ( $F = 1$ ) that maximizes  $J_0$
  2. Create all combinations of  $F+1$  features including the previous winner and compute  $J_0$
  3. Select the combination that maximizes  $J_0$
  4. Repeat steps 2 and 3 until  $F = M$
- Nesting: once a feature has been selected it cannot be discarded

# LDA

---

- An alternative way to select features with high discriminative power is to use linear discriminant analysis (LDA)
- LDA is similar to PCA, but the eigenanalysis is performed on the matrix  $S_w^{-1}S_b$  instead of  $C_x$
- Like in PCA, the transformation matrix  $A$  is re-ordered according to the eigenvalues  $\lambda_i$  from high to low
- Then we can use only the top  $M$  rows of  $A$ , where  $M < \text{rank of } S_w^{-1}S_b$
- LDA projects the data into a few directions maximizing class separability

# Classification

---

- We have:
  - A taxonomy of classes
  - A representative sample of the signals to be classified
  - An optimal set of features
- Goals:
  - Learn class models from the data
  - Classify new instances using these models
- Strategies:
  - Supervised: models learned by example
  - Unsupervised: models are uncovered from unlabeled data

# Instance-based learning

---

- Simple classification can be performed by measuring the distance between instances.
- Nearest-neighbor classification:
  - Measures distance between new sample and all samples in the training set
  - Selects the class of the closest training sample
- k-nearest neighbors (k-NN) classifier:
  - Measures distance between new sample and all samples in the training set
  - Identifies the k nearest neighbors
  - Selects the class that was more often picked.

# Instance-based learning

---

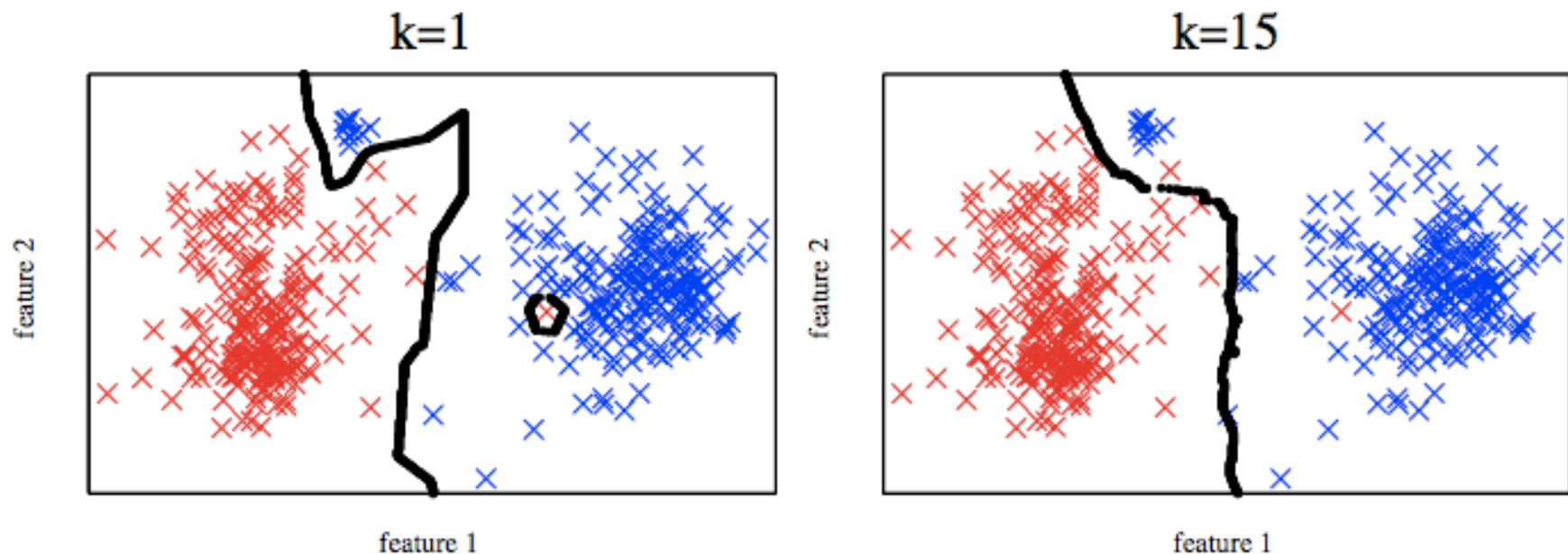
- In both these cases, training is reduced to storing the labeled training instances for comparison
- Known as “lazy” or “memory-based” learning.
- All computations are performed during classification
- Complexity increases with number of training instances.
- Alternatively, we can store only a few class prototypes/models (e.g. class centroids)



# Instance-based learning

---

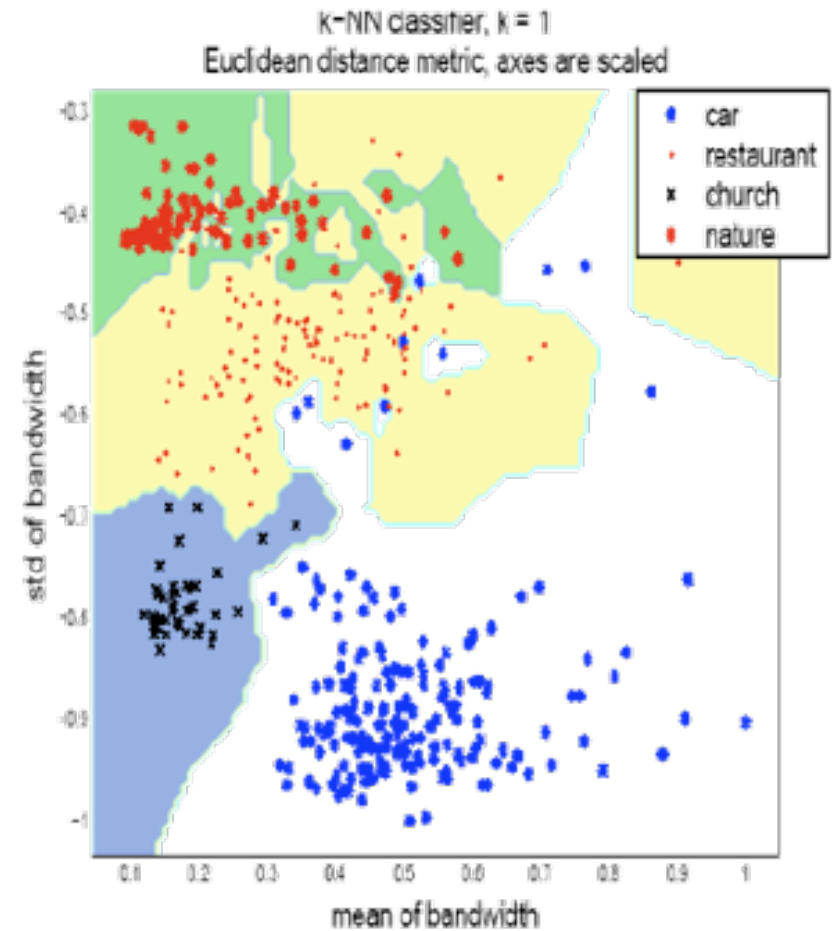
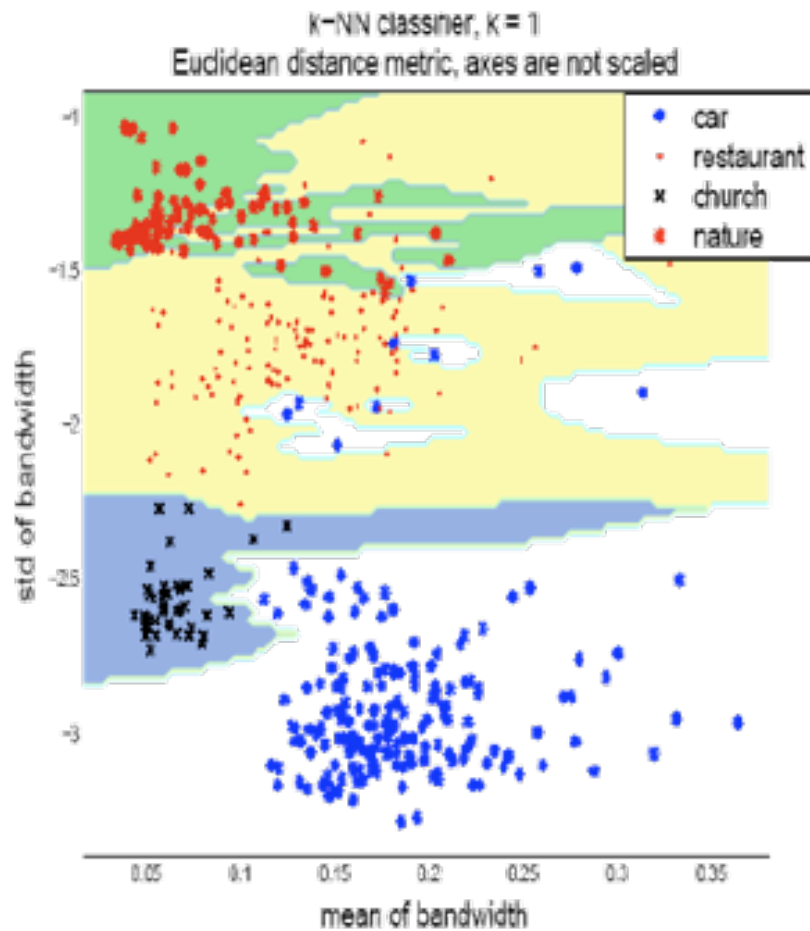
- We need to choose  $k$  to avoid overfitting, e.g.,  $k = \sqrt{L}$  where  $L$  is the number of training samples



- Works well for well-separated classes; and an appropriate combination of distance metric and feature pre-processing

# Instance-based learning

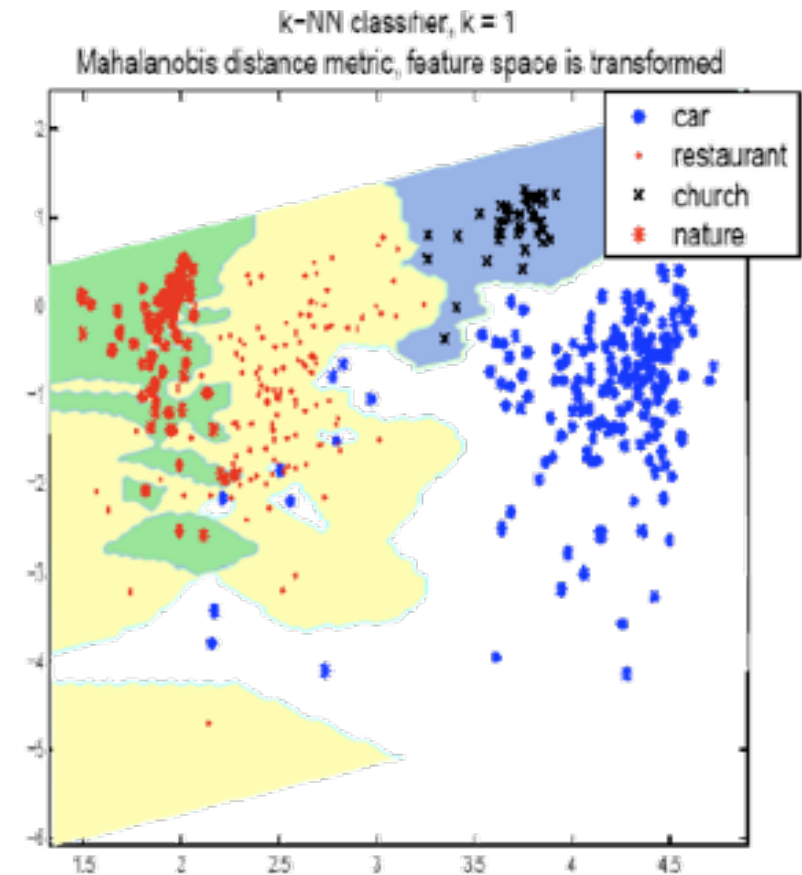
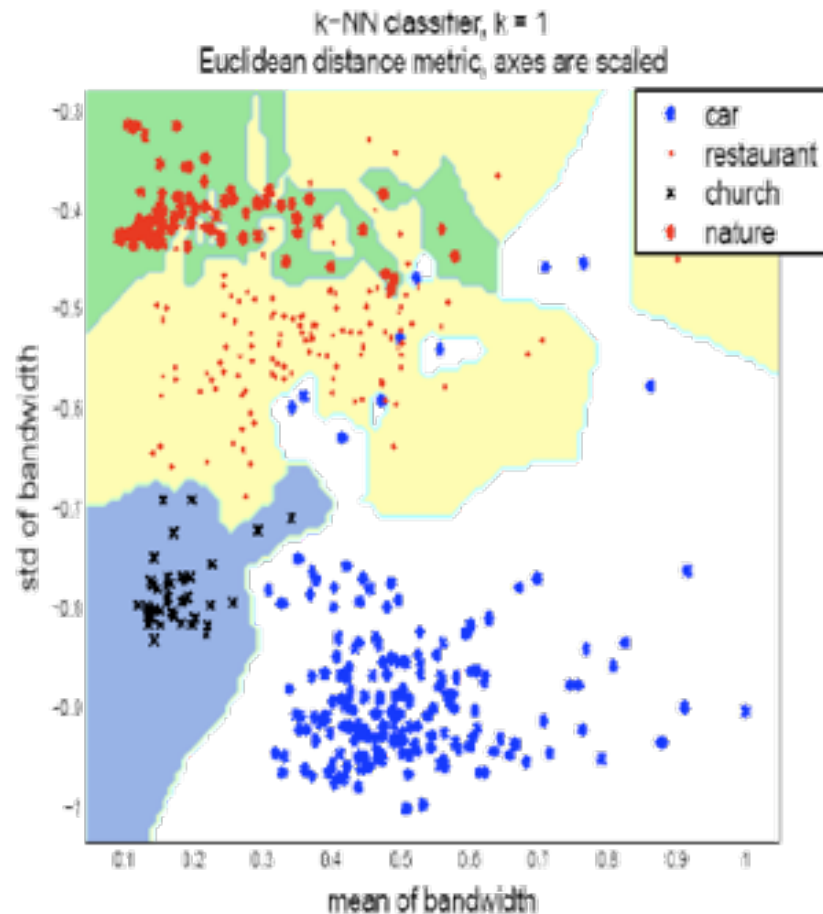
- The effect of standardization (from Peltonen's MSc thesis, 2001)



# Instance-based learning

- Mahalanobis distance: considers the underlying distribution

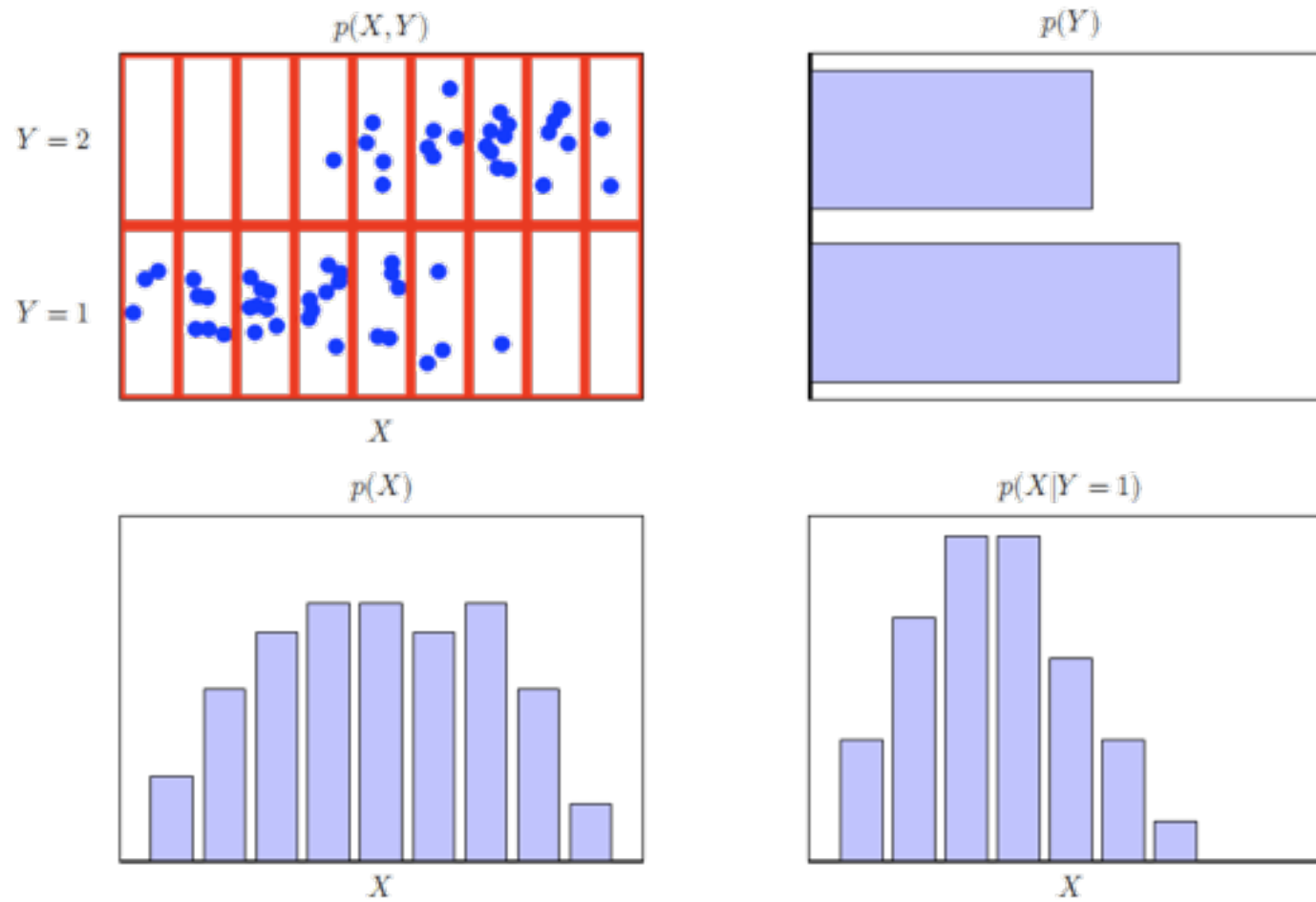
$$d(\mathbf{x}, \mathbf{y}) = \sqrt{(\mathbf{x} - \mathbf{y})^T C^{-1} (\mathbf{x} - \mathbf{y})}$$



# Probability

---

- Let us assume that the observations  $X$  and classes  $Y$  are random variables



\*From Bishop's Machine Learning book, 2007

# Probability

---

$L$  = total number of blue dots

$c_i$  = number of dots in column  $i$

$r_j$  = number of dots in row  $j$

$n_{ij}$  = number of dots in cell  $ij$

Joint Probability

$$\left\{ P(X, Y) = P(Y, X) = \frac{n_{ij}}{L} \right\}$$

Symmetry rule

Marginal Probability

$$\left\{ P(X) = \frac{c_i}{L} = \sum_j P(X, Y) \right\}$$

Sum rule

Conditional Probability

$$\left\{ P(Y|X) = \frac{n_{ij}}{c_i} \right\}$$

$$P(X, Y) = \frac{n_{ij}}{L} = \frac{n_{ij}}{c_i} \frac{c_i}{L} = \underbrace{P(Y|X)P(X)}$$

Product rule

# Probability

---

- Thus we can derive Bayes' theorem as:

Posterior: probability of class  $i$  given an observation  $x$

Likelihood: Probability of observation  $x$ , given class  $i$

$$P(\text{class}_i|x) = \frac{\overbrace{P(x|\text{class}_i)P(\text{class}_i)} \left. \vphantom{\frac{P(x|\text{class}_i)P(\text{class}_i)}}{\underbrace{P(x)}}} \right\} \text{Prior: Probability of class } i$$

Marginal Likelihood: Normalizing constant (same for all classes) that ensures posterior adds to 1

$$P(x) = \sum_i P(x|\text{class}_i)P(\text{class}_i)$$

# Probabilistic Classifiers

---

- Classification: finding the class with the highest probability given the observation  $x$
- Find  $i$  that maximizes the posterior probability  $P(\text{class}_i|x)$  -> Maximum A Posteriori (MAP)
- Since  $P(x)$  is the same for all classes, this is equivalent to:

$$\underset{i}{\operatorname{argmax}} [P(x|\text{class}_i)P(\text{class}_i)]$$

- From the training data we can learn the likelihood  $P(x|\text{class}_i)$  and the prior  $P(\text{class}_i)$

# Gaussian Mixture Model

---

- We can model (parameterize) the likelihood using a Gaussian Mixture Model (GMM) -> the weighted sum of K multidimensional Gaussian distributions:

$$P(x|\text{class}_i) = \sum_{k=1}^K w_{ik} \mathcal{N}(x; \mu_{ik}, C_{ik})$$

- Where  $w_{ik}$  are the mixing weights and:

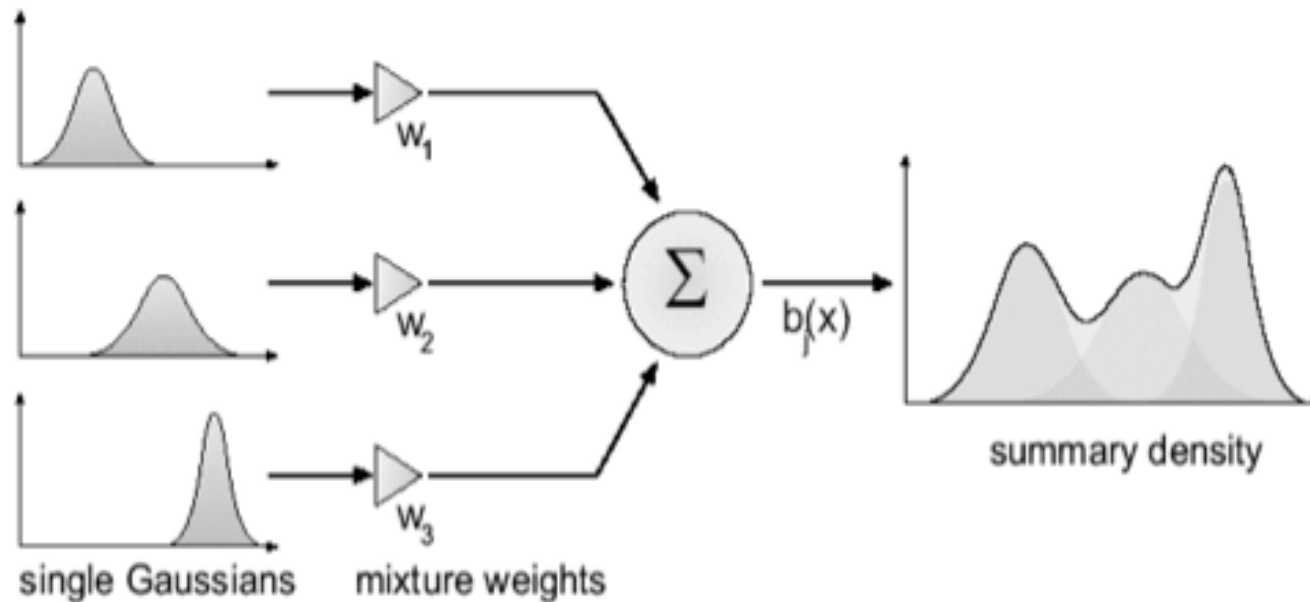
$$\mathcal{N}(\mathbf{x}; \mu, \mathbf{C}_x) = \frac{1}{(2\pi)^{D/2} |\mathbf{C}_x|^{1/2}} e^{-\frac{1}{2}(\mathbf{x}-\mu)^T \mathbf{C}_x^{-1}(\mathbf{x}-\mu)}$$



# Gaussian Mixture Model

---

- 1-D GMM (Heittola, 2004)



- With a sufficiently large  $K$  a GMM can approximate any distribution
- However, increasing  $K$  increases the complexity of the model and compromises its ability to generalize

# Gaussian Mixture Model

---

- The model is parametric, consisting of  $K$  weights, mean vectors and covariance matrices for every class.
- If features are decorrelated, then we can use diagonal covariance matrices, thus considerably reducing the number of parameters to be estimated (common approximation)
- Parameters can be estimated using the Expectation-Maximization (EM) algorithm (Dempster et al, 1977).
- EM is an iterative algorithm whose objective is to find the set of parameters that maximizes the likelihood.

# K-means

---

- Dataset:  $L$  observations of a  $D$ -dimensional variable  $\mathbf{x}$
- Goal: find the partition into  $K$  clusters, each represented by a prototype  $\mu_k$ , that minimizes the distortion:

$$J = \sum_{l=1}^L \sum_{k=1}^K r_{lk} \|\mathbf{x}_l - \mu_k\|_2^2$$

- where the “responsibility” function  $r_{lk} = 1$  if the  $l^{\text{th}}$  observation is assigned to cluster  $k$ , 0 otherwise
- We don’t know the optimal  $r_{lk}$  and  $\mu_k$

# K-means

---

1. Choose initial values for  $\mu_k$

2. E (expectation)-step: keeping  $\mu_k$  fixed, minimize J with respect to  $r_{lk}$

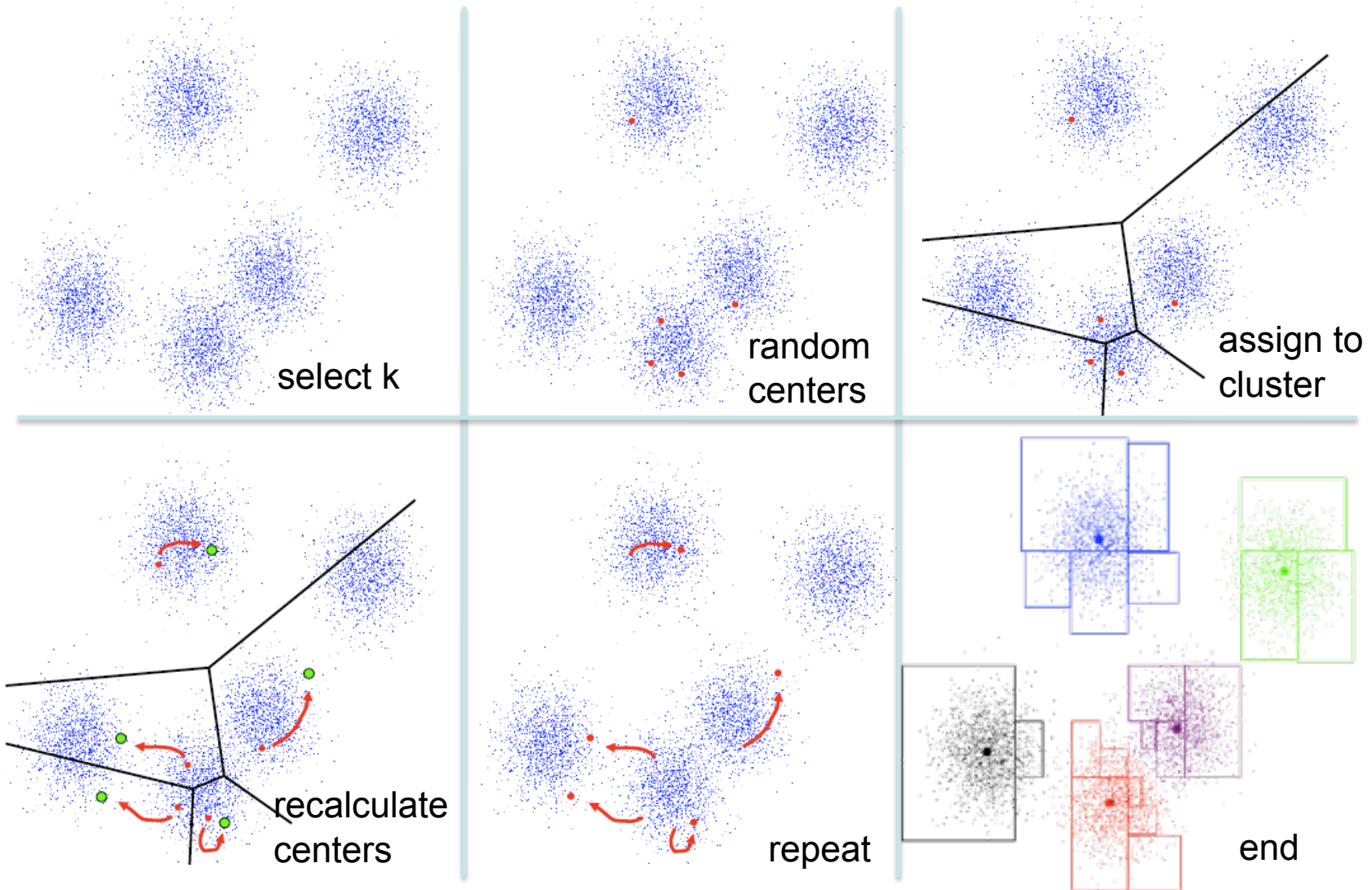
$$r_{lk} = \begin{cases} 1 & \text{if } k = \operatorname{argmin}_k \|\mathbf{x}_l - \mu_k\|_2^2 \\ 0 & \text{otherwise} \end{cases}$$

3. M (maximization)-step: keeping  $r_{lk}$  fixed, minimize J with respect to  $\mu_k$

$$\mu_k = \frac{\sum_l r_{lk} \mathbf{x}_l}{\sum_l r_{lk}}$$

4. repeat 2 and 3 until J or the parameters stop changing

# K-means



\*from <http://www.autonlab.org/tutorials/kmeans11.pdf>

# K-means

---

- Many possible improvements (see, e.g. Dan Pelleg and Andrew Moore's work)
  - does not always converge to the optimal solution -> run k-means multiple times with different random initializations
  - sensitive to initial centers -> start with random datapoint as center; next center is farthest datapoint from closest center
  - sensitive to choice of K -> find the K that minimizes the Schwarz criterion (see Moore's tutorial):

$$\sum_l^L \|\mathbf{x}_l^{(k)} - \mu_k\|_2^2 + \lambda(DK) \log L$$

# EM Algorithm

---

- GMM: each cluster corresponds to a weighted Gaussian
- Soft responsibility function: conditional probability of belonging to Gaussian  $k$  given observation  $\mathbf{x}_l$

$$\gamma_{lk} = \frac{w_k \mathcal{N}(\mathbf{x}_l; \mu_k, \mathbf{C}_k)}{\sum_{j=1}^K w_j \mathcal{N}(\mathbf{x}_l; \mu_j, \mathbf{C}_j)}$$

- Goal: find the parameters that maximize

$$\log\{p(X|\mu, \mathbf{C}, \mathbf{w})\} = \sum_{l=1}^L \log \left\{ \sum_{k=1}^K w_k \mathcal{N}(\mathbf{x}_l; \mu_k, \mathbf{C}_k) \right\}$$

# EM Algorithm

---

1. Initialize  $\mu_k$ ,  $C_k$  and  $w_k$
2. E-step: evaluate responsibilities  $\gamma_{lk}$  using current parameters
3. M-step: re-estimate parameters using current responsibilities

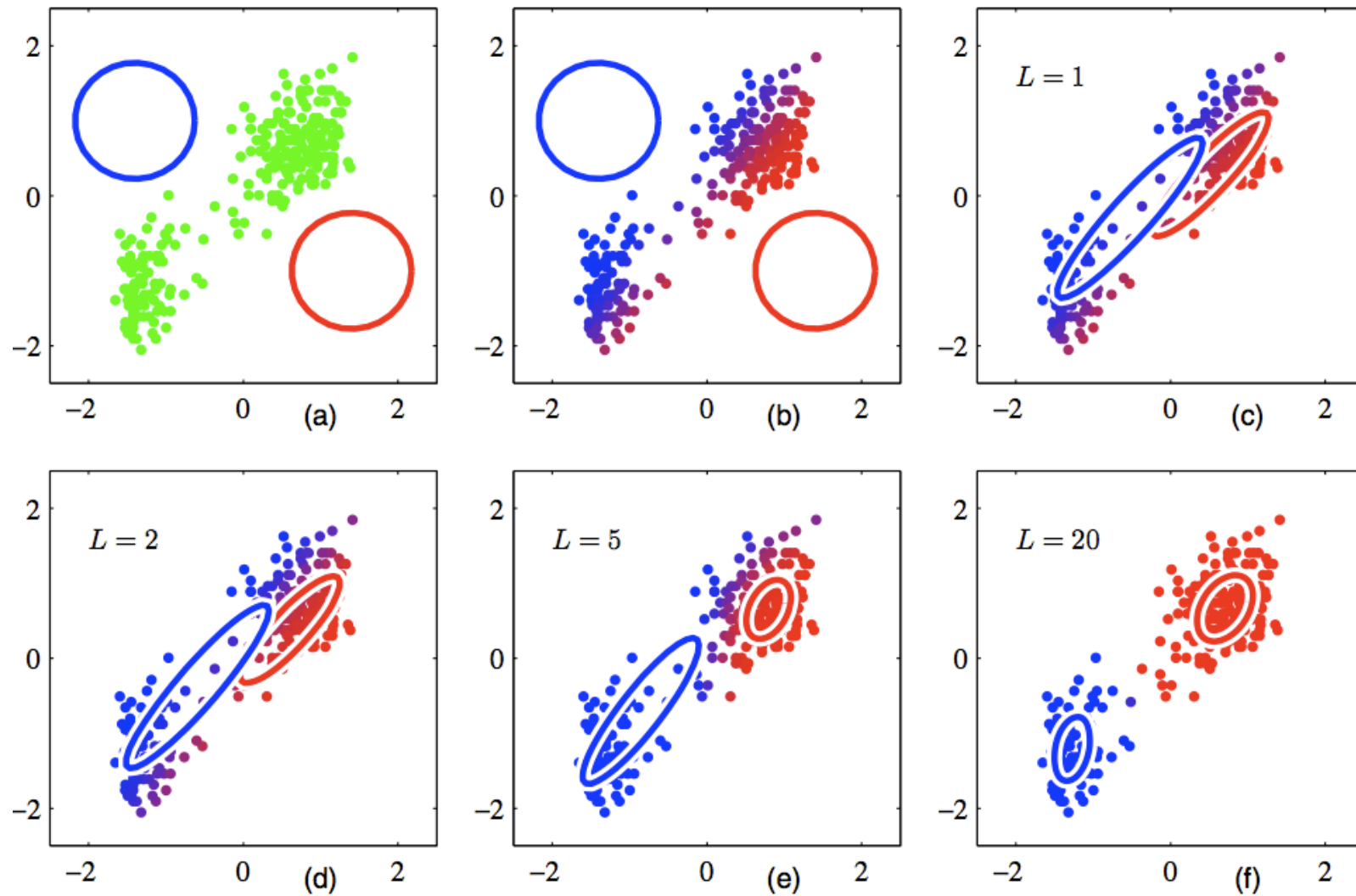
$$\mu_k^{\text{new}} = \frac{\sum_l \gamma_{lk} \mathbf{x}_l}{\sum_l \gamma_{lk}} \quad w_k^{\text{new}} = \frac{\sum_l \gamma_{lk}}{L}$$

$$C_k^{\text{new}} = \frac{\sum_l \gamma_{lk} (\mathbf{x}_l - \mu_k^{\text{new}})(\mathbf{x}_l - \mu_k^{\text{new}})^T}{\sum_l \gamma_{lk}}$$

4. repeat 2 and 3 until the log likelihood or the parameters stop changing



# EM Algorithm



\*From Bishop's Machine Learning book, 2007

# EM Algorithm

---

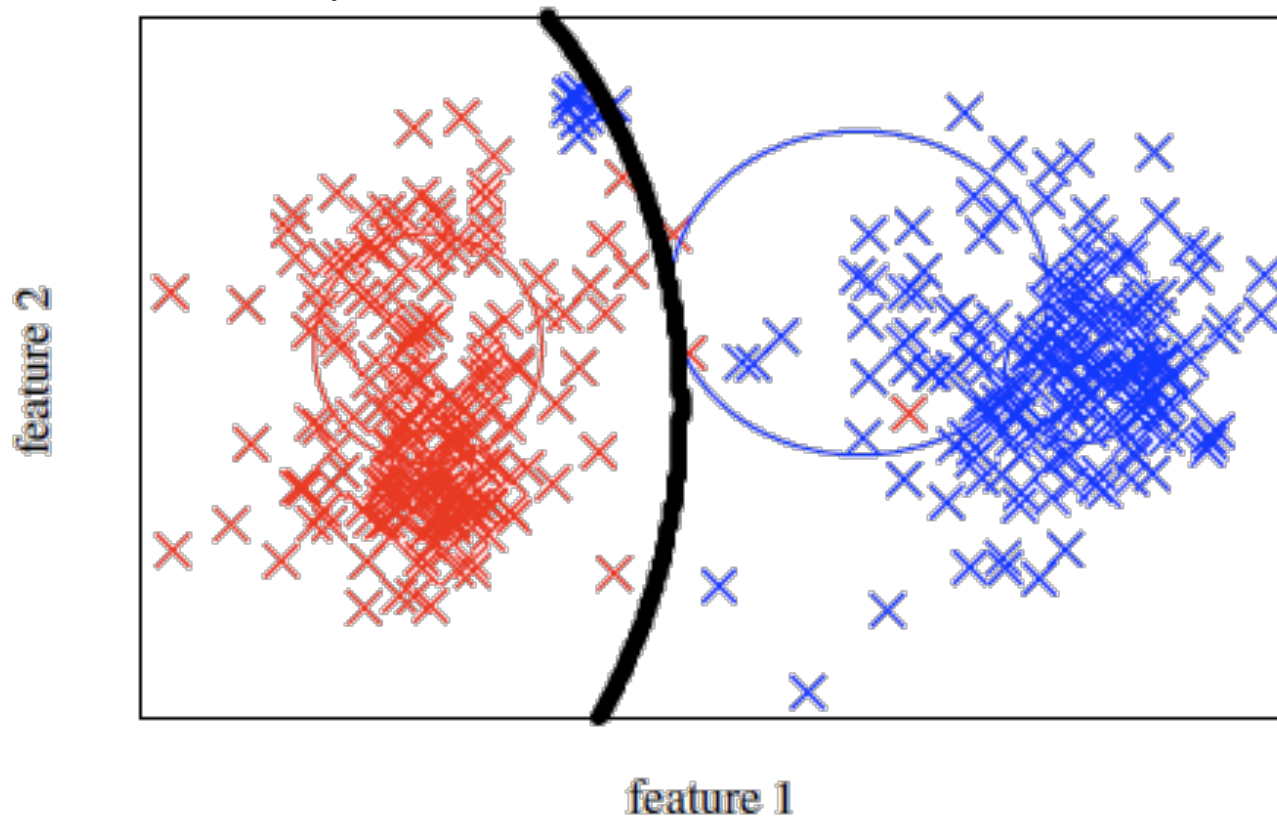
- EM is both more expensive and slower to converge than K-means
- Common trick: run K-means to initialize EM
  - Find cluster centers (means)
  - Compute sample covariances of the found clusters
  - Mixing weights  $\rightarrow$  fraction of  $L$  assigned to each cluster

# MAP Classification

---

- After learning the likelihood and the prior during training, we can classify new instances based on MAP classification:

$$\operatorname{argmax}_i [P(x|\text{class}_i)P(\text{class}_i)]$$



# References

---

- This lecture borrows heavily from Emmanuel Vincent's lecture notes on instrument classification (QMUL - Music Analysis and Synthesis) and from Anssi Klapuri's lecture notes on Audio Signal Classification (ISMIR 2004 Graduate School: <http://ismir2004.ismir.net/graduate.html>)
- Bishop, C.M. Pattern Recognition and Machine Learning. Springer (2007)
- Duda, R.O., Hart, P.E. and Stork, D.G. Pattern Classification (2nd Ed). John Wiley & Sons (2000)
- Witten, I. and Frank, E. Data Mining: Practical Machine Learning Tools and Techniques. Morgan Kaufmann (2005)
- Shlens, J. A Tutorial on Principal Component Analysis, Version 3.01 (2009): <http://www.snl.salk.edu/~shlens/pca.pdf>
- Moore, A. Statistical Data Mining Tutorials: <http://www.autonlab.org/tutorials/>